

# Test Report

**Report No.:** MTi240125015-05E2

**Date of issue:** 2024-03-26

**Applicant:** Shenzhen Huiying Electronics Co., Ltd.

**Product:** Levitating Light Bulb

**Model(s):** VA1213, HY20001, HY22001, EKM-MFB-A1,  
UVEHAS23, XR-3-FLBA5

**FCC ID:** 2BE7G-VA1213

Shenzhen Microtest Co., Ltd.

<http://www.mtitest.com>

## Instructions

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2. The test results in this test report are only responsible for the samples submitted
3. This test report is invalid without the seal and signature of the laboratory.
4. This test report is invalid if transferred, altered, or tampered with in any form without authorization.
5. Any objection to this test report shall be submitted to the laboratory within 15 days from the date of receipt of the report.

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Test Result Certification	
<b>Applicant:</b>	Shenzhen Huiying Electronics Co., Ltd.
<b>Address:</b>	R.201, Building 1, Dadiyuan, Jinbi Road, Cuizhu Street, Luohu District, Shenzhen, China 518000
<b>Manufacturer:</b>	Shenzhen Huiying Electronics Co., Ltd.
<b>Address:</b>	R.201, Building 1, Dadiyuan, Jinbi Road, Cuizhu Street, Luohu District, Shenzhen, China 518000
<b>Product description</b>	
<b>Product name:</b>	Levitating Light Bulb
<b>Trademark:</b>	VGAzer, exekoml, UVEHAS,DIDWI
<b>Model name:</b>	VA1213
<b>Series Model:</b>	HY20001, HY22001, EKM-MFB-A1, UVEHAS23, XR-3-FLBA5
<b>Standards:</b>	FCC CFR 47 PART 1, § 1.1310 FCC CFR 47 PART 2, § 2.1091
<b>Test method:</b>	KDB 680106 D01 Wireless Power Transfer v04
<b>Date of Test</b>	
<b>Date of test:</b>	2024-03-05 to 2024-03-26
<b>Test result:</b>	Pass

Test Engineer :

*Letter Lan.*

(Letter Lan)

Reviewed By :

*Leon Chen*

(Leon Chen)

Approved By :

*Tom Xue*

(Tom Xue)

## 1 General Description

### 1.1 Description of the EUT

Product name:	Levitating Light Bulb
Model name:	VA1213
Series Model(s):	HY20001, HY22001, EKM-MFB-A1, UVEHAS23, XR-3-FLBA5
Model difference:	All the models are the same circuit and module, except the models name colour and appearance.
Electrical rating:	Input: DC 12V/ 400mAh Output: DC 5V/ 150mAh
Accessories:	Adaptor: Model: HP24L-1202000-AVU-S Input: 100-240V - 50/60Hz 0.8A Output: 12V=2A
Hardware version:	V-R2
Software version:	VA1213
Test sample(s) number:	MTi240125015-05S1001 MTi240125015-05S1002
<b>RF specification</b>	
Operating frequency range:	115-205KHz
Modulation type:	ASK
Antenna(s) type:	Coil Antenna

### 1.2 Description of test modes

All the test modes were carried out with the EUT in normal operation, the final test mode of the EUT was the worst test mode for emission test, which was shown in this report and defined as:

No.	Emission test modes
Mode1	Wireless Output(bulb)
Mode2	stand dy

### 1.3 Description of support units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Support equipment list			
Description	Model	Serial No.	Manufacturer
/	/	/	/
Support cable list			
Description	Length (m)	From	To
/	/	/	/

## 2 Measurement uncertainty

Parameter	Expanded Uncertainty
Magnetic field measurement (9kHz~30MHz)	$\pm 18.6\%$
Electric field measurements (9kHz~30MHz)	$\pm 18.6\%$

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of  $k=2$ .

### 3 Test facilities and accreditations

#### 3.1 Test laboratory

Test laboratory:	Shenzhen Microtest Co., Ltd.
Test site location:	101, No. 7, Zone 2, Xinxing Industrial Park, Fuhai Avenue, Xinhe Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China
Telephone:	(86-755)88850135
Fax:	(86-755)88850136
CNAS Registration No.:	CNAS L5868
FCC Registration No.:	448573

#### 4 List of test equipment

No.	Equipment	Manufacturer	Model	Serial No.	Cal. date	Cal. Due
MTi-E115	Electric and Magnetic Field Probe – Analyzer	Narda	EHP-200A	101166	2023/08/15	2026/08/14



## 5 Test result

### 5.1.1 Requirement

§1.1310: The criteria listed in the following table shall be used to evaluate the environment impact of human exposure to radio frequency (RF) radiation as specified in §1.1307(b), except in the case of portable devices which shall be evaluated according to the provisions of FCC part 2.1093 of this chapter.

**Table 1 to §1.1310(e)(1) - Limits for Maximum Permissible Exposure (MPE)**

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm <sup>2</sup> )	Averaging time (minutes)
<b>(i) Limits for Occupational/Controlled Exposure</b>				
0.3-3.0	614	1.63	*(100)	≤6
3.0-30	1842/f	4.89/f	*(900/f <sup>2</sup> )	<6
30-300	61.4	0.163	1.0	<6
300-1500			f/300	<6
1500-100000			5	<6
<b>(ii) Limits for General Population/Uncontrolled Exposure</b>				
0.3-1.34	614	1.63	*(100)	<30
1.34-30	824/f	2.19/f	*(180/f <sup>2</sup> )	<30
30-300	27.5	0.073	0.2	<30
300-1500			f/1500	<30
1500-100000			1.0	<30

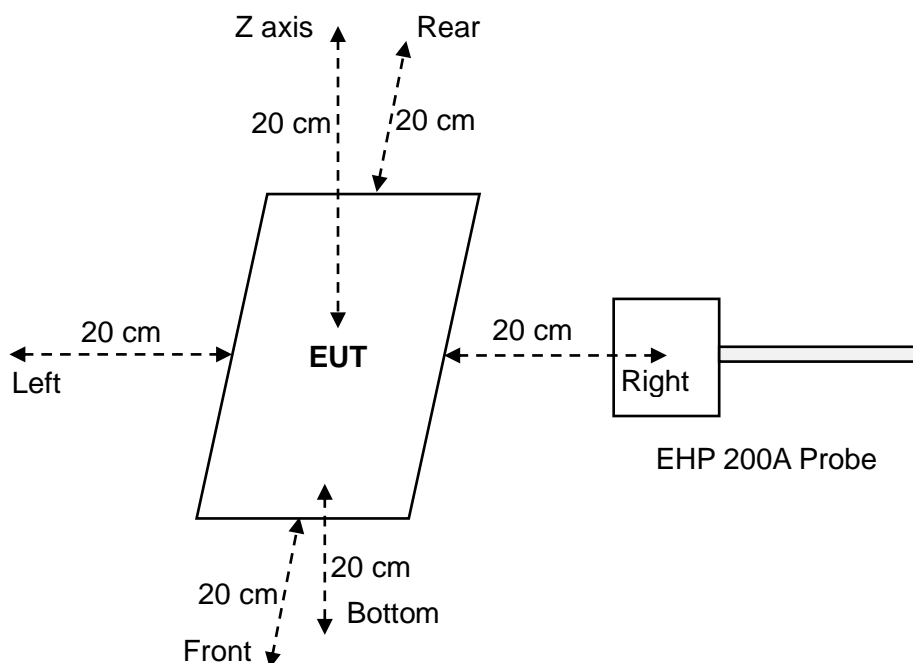
f = frequency in MHz

\* = Plane-wave equivalent power density

**Note 1:** Occupational/controlled exposure limits apply in situations in which persons are exposed as a consequence of their employment provided those persons are fully aware of the potential for exposure and can exercise control over their exposure.

**Note 2:** General population/uncontrolled exposure limits apply in situations in which the general public may be exposed, or in which persons who are exposed as a consequence of their employment may not be fully aware of the potential for exposure or cannot exercise control over their exposure.

## 5.2 Test setup



## 5.3 Test Procedures

- The RF exposure test was performed in anechoic chamber.
- E and H-field measurements should be made with these devices considered to meet the § 2.1091-Mobile conditions ("generally be used in such a way that a separation distance of at least 20 centimeters is normally maintained between the RF source's radiating structure(s) and [the nearest person]").
- The highest emission level was recorded and compared with limit.
- The EUT was measured according to the dictates of KDB 680106 D01 Wireless Power Transfer v04.

## 5.4 Test results

VA1213:

Test condition 1: Mode 1 operating mode with client device (1 % battery status of client device)

Probe Position	E -field (V/m)			H-field (A/m)		
	Measurement	Limit	Percentage (%)	Measurement	Limit	Percentage (%)
Z axis	0.3727	614	0.20%	0.1330	1.63	12.90%
Left	0.4914			0.0921		
Right	0.7307			0.1129		
Front	0.6506			0.1077		
Rear	0.4919			0.1001		
bottom	1.2260			0.2103		

Test condition 2: Mode 1 operating mode with client device (50 % battery status of client device)

Probe Position	E -field (V/m)			H-field (A/m)		
	Measurement	Limit	Max. Percentage (%)	Measurement	Limit	Max. Percentage (%)
Z axis	0.3815	614	0.20%	0.1301	1.63	12.39%
Left	0.5048			0.0957		
Right	0.7473			0.1057		
Front	0.6427			0.1089		
Rear	0.4793			0.0956		
Bottom	1.2248			0.202		

Test condition 3: Mode 1 operating mode with client device (99 % battery status of client device)

Probe Position	E -field (V/m)			H-field (A/m)		
	Measurement	Limit	Percentage (%)	Measurement	Limit	Percentage (%)
Z axis	0.3709	61	0.20%	0.1296	1.63	12.58%
Left	0.4889			0.0846		
Right	0.7229			0.1048		
Front	0.6421			0.1039		
Rear	0.4753			0.092		
bottom	1.2128			0.2051		

**HY20001:**
**Test condition 1: Mode 1 operating mode with client device (1 % battery status of client device)**

Probe Position	E -field (V/m)			H-field (A/m)		
	Measurement	Limit	Percentage (%)	Measurement	Limit	Percentage (%)
Z axis	0.3632	614	0.20%	0.1321	1.63	12.69%
Left	0.4851			0.0821		
Right	0.7108			0.1268		
Front	0.6321			0.1001		
Rear	0.4901			0.1142		
bottom	1.2360			0.2068		

**Test condition 2: Mode 1 operating mode with client device (50 % battery status of client device)**

Probe Position	E -field (V/m)			H-field (A/m)		
	Measurement	Limit	Max. Percentage (%)	Measurement	Limit	Max. Percentage (%)
Z axis	0.3452	614	0.20%	0.13	1.63	12.39%
Left	0.4684			0.0841		
Right	0.7072			0.1193		
Front	0.633			0.1065		
Rear	0.4792			0.1161		
Bottom	1.233			0.2061		

**Test condition 3: Mode 1 operating mode with client device (99 % battery status of client device)**

Probe Position	E -field (V/m)			H-field (A/m)		
	Measurement	Limit	Percentage (%)	Measurement	Limit	Percentage (%)
Z axis	0.3563	61	0.20%	0.1279	1.63	12.66%
Left	0.4741			0.0732		
Right	0.7079			0.12		
Front	0.6307			0.0929		
Rear	0.4808			0.1045		
bottom	1.2223			0.2063		

## Photographs of the Test Setup

See the Appendix - Test Setup Photos.

## Photographs of the EUT

See the Appendix - EUT Photos.

**----End of Report----**